

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/574,946	UEHARA, MASAHIRO	0
Examiner	Art Unit	
Thien M. Le	2876	

	SEAR	CHED	
Class	Subclass	Date	Examiner
235	380		
	375		
	382		
	381		
	492		
	486		
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	487,383		
705	1,26		
	65,44		,
	13		
455	41.2		
	552.1		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
235	380				
	493	11/26/2007	LTM		

DATE	LTM
1/25/2007	LTM
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